			_			As of January 29, 202		
		nesday	, March	า 18				
08:30-10:00 Plenary Session 3				Main Room (Matahari I, II, III)				
rienary Chair:			Rajendra	an				
3:30	9:15	PL-6		Nanocarbon Interconnects - from 1D to 3D	Cary Y. Yang	Santa Clara University		
9:15	10:00	PL-7		Industrial LED development: From red to UV and from efficient components to	David Lacey	Osram Opto Semiconductors		
10:00-1		1 - 1		Smart devices  Main Room (Matahari I, II, III)	- aa -a,			
hort B	reak							
0:15-1				Room A (Matahari I)				
ession		h Ductor	i Daulli	Variability Modeling ning Zhang				
Chairs:	1		i, Paul Li	General Formula to Capture the Impact of Dummy Gates on Layout Dependent	Kaiwa Via	NVD Comica advistora		
10:15	10:40	7A-1		Effects Modeling of Multi-finger MOSFETs	Kejun Xia	NXP Semiconductors		
0:40	11:05	7A-2		An Accurate Structure Generation and Simulation of LER Affected NWFET	Agam Jain	Indian Institute of Technology Roorkee		
1:05	11:30	7A-3		Analysis on Process Variation Effect of 3D NAND Flash Memory Cell Through Machine Learning Model	Jang Kyu Lee	Seoul National University		
1:30	11:55	7A-4		Superior Work Function Variability Performance of Horizontally Stacked Nanosheet FETs for Sub-7-nm Technology and Beyond	Akhil Sudarsanan	Indian Institute of Technology Hyderabad		
2:20-1	3:20			Authors' Interview / Lunch Break (Rooms Etoile and Grand BR II)		Try del dodd		
0:15-1	2:20			Room B (Matahari III)				
ession		<b></b>		Advanced Transistors				
hairs:			ukinori N	Process-induced Vt Variability in Nanoscale FinFETs: Does Vt Extraction Methods				
10:15	10:40	7B-1		Have Any Impact	Mandar S. Bhoir	IIT Gandhinagar		
0:40	11:05	7B-2		Impact of LER on Mismatch in Nanosheet Transistors for 5nm-CMOS	Chandan Kumar Jha	IIT DELHI		
11:05	11:30	7B-3		Possibility of Ultralow Power Rectenna with Super Steep SS "PN-Body Tied SOI FET" and High Impedance Antenna	Ryota Yanagi	Kanazawa Institute of Technology		
11:30	11:55	7B-4		Digital Type CMOS-MEMS Cointegrated Pressure Sensor Fabricated Using Cost- Effective Minimal-Fab Process	Yongxun Liu	National Institute of Advanced Industria Science and Technology (AIST)		
12:20-1	3:20			Authors' Interview / Lunch Break (Rooms Etoile and Grand BR II)		Science and reemiology (Alst)		
10:15-1	2:20			Room C (Grand Ballroom I)				
Session		ا ا ا		Materials Processing				
0:15	10:40	7C-1		hun Jeon  High Volume Semiconductor Manufacturing Using Nanoimprint Lithography	Yukio Takabayashi	CANON Inc.		
		+			,			
0:40	11:05	7C-2	Invited	COTS Semiconductor Components for the New Space Industry	Harshad Bokil	Ispace		
1:05	11:30	7C-3		Bi-Objective Indirect Optimization of Robotic Transportation Task Assignment Based on Auction Mechanism	Souleymane Moussa Goumeye	Lineact Cesi		
1:30	11:55	7C-4	Invited	Switching and Charge Trapping in HfO2-based Ferroelectric FETs: An Overview and Potential Applications	Halid Mulaosmanovic	NaMLab gGmbH		
1:55	12:20	7C-5		Ferroelectricity Enhancement in Hf0.5Zr0.5O2 Capacitors by Incorporating Ta2O5 Dielectric Seed Layers	Venkateswarlu Gaddam	Korea Advanced Institute of Science and		
2:20-1	3:20			Authors' Interview / Lunch Break (Rooms Etoile and Grand BR II)		Technology		
0:15-1	2:20			Room D (Grand Ballroom III)				
ession				2D Materials and Devices				
hairs:			iva Kanta		1			
0:15	10:40	7D-1	Invited	Metals at the Atomic Limit	Joshua Robinson	The Pennsylvania State University		
0:40	11:05	7D-2		Synthesis of MoS2(1-x)Te2x by Sputtering and the Change in the Physical Properties and Structure Depending on the Chalcogen Composition	Yusuke Hibino	Meiji University		
1:05	11:30	7D-3	Invited	Inter-layer Charge and Energy Transfer in Layered Heterojunction Devices	Kausik Majumdar	Indian Institute of Science Bangalore India		
1:30	11:55	7D-4	Invited	Electric-double-layer MoS2 Transistors and Their Neuromorphic Device	Jie Jiang	Central South University		
12:20-1	3-20			Applications  Authors' Interview / Lunch Break (Rooms Etoile and Grand BR II)				

3:20-15		iesday,	March			
				Room A (Matahari I)		
ession				Neural Network and NVM 2		
hairs:	Wai Yie	Leong, C	hetan A	rora Neural Network Based Design Optimization of 14-Nm Node Fully-Depleted SOI		
3:20	13:45	8A-1		FET for SoC and 3DIC Applications	Hyeok Yun	POSTECH
3:45	14:10	8A-2		Graphene Muscle with Artificial Intelligence	Ning-Qin Deng	Tsinghua University
1:10	14:35	8A-3		Methodology to Predict Random Telegraph Noise Induced Threshold Voltage Shift Using Machine Learning	Eunseok Oh	Seoul National University
1:35	15:00	8A-4		Development of Non-Volatile Tunnel-FET Memory as a Synaptic Device for Low-Power Spiking Neural Networks	Hisashi Kino	Tohoku University
5:00-15	5:20			Authors' Interview / Coffee Break		
3:20-15	5:00			Room B (Matahari III)		
ession				Manufacturing and Characterization		
hairs:	Bernard	Lim, Kei	zo Hirag	a Metrology and Inspection: Challenges and Solutions for Emerging Technology		
3:20	13:45	8B-1	Invited	Nodes	Arun Srivatsa	Applied Materials
3:45	14:10	8B-2		Physical Model for Rapid Thermal Annealing (RTA) Induced Mechanical Stress	Tingyou Lin	Vanguard International Semiconductor Corporation
4:10	14:35	8B-3		Residual Stress Analysis and Structural Parameters Optimization of Corrugated Diaphragms Applied to MEMS Device	Chuying Tang	Wuhan University
4:35	15:00	8B-4		Emerging memory for IoT	Mohd Azizi Chik	UNIMAP & Silterra Malaysia Sdn Bhd
5:00-15	5:20			Authors' Interview / Coffee Break		
3:20-15	5:00			Room C (Grand Ballroom I)		
ession	8C			Emerging Memory for IoT		
hairs:	Sachin S	onkusal				
3:20	13:45	8C-1	Invited	Ferroelectric-HfO2 Devices Technology and Manufacturing for Memory and Logic Applications	Shinji Migita	National Institute of Advanced Industri Science and Technology (AIST)
3:45	14:10	8C-2		Fabrication and Characterization of Ferroelectric HfZrO-based Synaptic Transistors with Multi-state Plasticity	Tianqi Lu	Tsinghua University
4:10	14:35	8C-3		A Novel Capacitor-based Stateful Logic Operation Scheme for In-memory Computing in 1T1R RRAM Array	Wen Sheng Shen	Peking University
4:35	15:00	8C-4		A Novel Bi-Functional Memory-PUF Module Utilizing Adjustable Switching Window of RRAM	Bohan Lin	Tsinghua University
5:00-15	5:20			Authors' Interview / Coffee Break		
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3:20-15	5:00			Room D (Grand Ballroom III)		
				Focus Session 3: Packaging and Heterogeneous Integration		
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ession hairs:	8D	<b>Supta, Ta</b> 8D-1		Focus Session 3: Packaging and Heterogeneous Integration Fukushima Laser-Assisted Bonding (LAB), Its Bonding Materials, and Their Applications	Kwang-Seong Choi	Electronics and Telecommunications Research Institute
ession hairs: 3:20	8D Piyush 0			Focus Session 3: Packaging and Heterogeneous Integration Fukushima	Kwang-Seong Choi Sungwook Moon	
ession hairs: 3:20 3:45	8D Piyush 0 13:45	8D-1	Invited Invited	Focus Session 3: Packaging and Heterogeneous Integration Fukushima Laser-Assisted Bonding (LAB), Its Bonding Materials, and Their Applications System-level Power Integrity Optimization Based on High-Density Capacitors for		Research Institute
ession hairs: 3:20 3:45 4:10	8D Piyush 0 13:45 14:10	8D-1 8D-2	Invited Invited Invited	Focus Session 3: Packaging and Heterogeneous Integration Fukushima  Laser-Assisted Bonding (LAB), Its Bonding Materials, and Their Applications  System-level Power Integrity Optimization Based on High-Density Capacitors for Enabling HPC/AI Applications	Sungwook Moon	Research Institute Samsung Electronics Co. Ltd. Tohoku University Seoul National University of Science ar
ession hairs: 3:20 3:45 4:10 4:35	8D Piyush (13:45) 14:10 14:35 15:00	8D-1 8D-2 8D-3	Invited Invited Invited	Focus Session 3: Packaging and Heterogeneous Integration Fukushima  Laser-Assisted Bonding (LAB), Its Bonding Materials, and Their Applications  System-level Power Integrity Optimization Based on High-Density Capacitors for Enabling HPC/AI Applications  Multilithic 3D and Heterogeneous Integration Using Capillary Self-Assembly	Sungwook Moon  Takafumi Fukushima	Research Institute Samsung Electronics Co. Ltd. Tohoku University
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	8D Piyush C 13:45 14:10 14:35 15:00 5:20 6T / CRES	8D-1 8D-2 8D-3 8D-4	Invited Invited Invited	Focus Session 3: Packaging and Heterogeneous Integration Fukushima  Laser-Assisted Bonding (LAB), Its Bonding Materials, and Their Applications  System-level Power Integrity Optimization Based on High-Density Capacitors for Enabling HPC/AI Applications  Multilithic 3D and Heterogeneous Integration Using Capillary Self-Assembly  Surface Planarization of Polymeric Dielectrics for FOWLP Applications  Authors' Interview / Coffee Break  Room A (Matahari I)	Sungwook Moon  Takafumi Fukushima	Research Institute Samsung Electronics Co. Ltd. Tohoku University Seoul National University of Science ar
ession hairs: 3:20 3:45 4:10 4:35 5:00-15	8D Piyush C 13:45 14:10 14:35 15:00 5:20 6T / CRES	8D-1 8D-2 8D-3 8D-4	Invited Invited Invited	Focus Session 3: Packaging and Heterogeneous Integration Fukushima  Laser-Assisted Bonding (LAB), Its Bonding Materials, and Their Applications  System-level Power Integrity Optimization Based on High-Density Capacitors for Enabling HPC/AI Applications  Multilithic 3D and Heterogeneous Integration Using Capillary Self-Assembly  Surface Planarization of Polymeric Dielectrics for FOWLP Applications  Authors' Interview / Coffee Break  Room A (Matahari I)  Room B (Matahari III)	Sungwook Moon  Takafumi Fukushima	Research Institute Samsung Electronics Co. Ltd. Tohoku University Seoul National University of Science ar
ession hairs: 3:20 3:45 4:10 4:35 5:00-15 5:20-17	8D Piyush (13:45) 14:10 14:35 15:00 5:20 5:20 5:7:00 9B	8D-1 8D-2 8D-3 8D-4	Invited Invited Invited Invited	Focus Session 3: Packaging and Heterogeneous Integration Fukushima  Laser-Assisted Bonding (LAB), Its Bonding Materials, and Their Applications  System-level Power Integrity Optimization Based on High-Density Capacitors for Enabling HPC/AI Applications  Multilithic 3D and Heterogeneous Integration Using Capillary Self-Assembly  Surface Planarization of Polymeric Dielectrics for FOWLP Applications  Authors' Interview / Coffee Break  Room A (Matahari I)	Sungwook Moon  Takafumi Fukushima	Research Institute Samsung Electronics Co. Ltd. Tohoku University Seoul National University of Science ar
ession hairs: 3:20 3:45 4:10 4:35 5:00-15 SAP (JS 5:20-17 ession	8D Piyush (13:45) 14:10 14:35 15:00 5:20 5:20 5:7:00 9B	8D-1 8D-2 8D-3 8D-4	Invited Invited Invited Invited	Focus Session 3: Packaging and Heterogeneous Integration Fukushima  Laser-Assisted Bonding (LAB), Its Bonding Materials, and Their Applications  System-level Power Integrity Optimization Based on High-Density Capacitors for Enabling HPC/AI Applications  Multilithic 3D and Heterogeneous Integration Using Capillary Self-Assembly  Surface Planarization of Polymeric Dielectrics for FOWLP Applications  Authors' Interview / Coffee Break  Room A (Matahari I)  Room B (Matahari III)  RF Device Modeling	Sungwook Moon  Takafumi Fukushima	Research Institute Samsung Electronics Co. Ltd. Tohoku University Seoul National University of Science ar
ession hairs: 3:20 3:45 4:10 4:35 5:00-15 5:20-17 ession hairs: 5:20	8D Piyush (13:45) 14:10 14:35 15:00 6:20 6:20 6:7 / CRES	8D-1 8D-2 8D-3 8D-4	Invited Invited Invited Invited	Focus Session 3: Packaging and Heterogeneous Integration Fukushima  Laser-Assisted Bonding (LAB), Its Bonding Materials, and Their Applications  System-level Power Integrity Optimization Based on High-Density Capacitors for Enabling HPC/AI Applications  Multilithic 3D and Heterogeneous Integration Using Capillary Self-Assembly  Surface Planarization of Polymeric Dielectrics for FOWLP Applications  Authors' Interview / Coffee Break  Room A (Matahari II)  Room B (Matahari III)  RF Device Modeling  erre Raskin	Sungwook Moon  Takafumi Fukushima  Sungdong Kim	Research Institute  Samsung Electronics Co. Ltd.  Tohoku University  Seoul National University of Science ar Technology  Université Catholique de Louvain  University of Illinois at Urbana-
ession hairs: 3:20 3:45 4:10 4:35 5:00-15 5:20-15 5:20-17 ession hairs:	8D Piyush C 13:45 14:10 14:35 15:00 6:20 6:20 6T / CRES 7:00 9B Harshit 15:45	8D-1 8D-2 8D-3 8D-4 <b>T) Agarwal</b> , 9B-1	Invited Invited Invited Invited	Focus Session 3: Packaging and Heterogeneous Integration Fukushima  Laser-Assisted Bonding (LAB), Its Bonding Materials, and Their Applications  System-level Power Integrity Optimization Based on High-Density Capacitors for Enabling HPC/AI Applications  Multilithic 3D and Heterogeneous Integration Using Capillary Self-Assembly  Surface Planarization of Polymeric Dielectrics for FOWLP Applications  Authors' Interview / Coffee Break  Room A (Matahari II)  RF Device Modeling  erre Raskin  SOI Devices and Substrates Towards RF and Millimeter Wave ICs  Modeling and Design of SiC-based High-Frequency Photoconductive Switches  Geometrical Dimension Impact for Performance of CMOS Based Compatible	Sungwook Moon  Takafumi Fukushima  Sungdong Kim  Jean-Pierre Raskin	Research Institute  Samsung Electronics Co. Ltd.  Tohoku University  Seoul National University of Science ar Technology  Université Catholique de Louvain  University of Illinois at Urbana-Champaign
ession hairs: 3:20 3:45 4:10 4:35 5:00-15 5:20-17 ession hairs: 5:20	8D Piyush (13:45) 14:10 14:35 15:00 6:20 6:20 6:7 / CRES 7:00 9B Harshit 15:45 16:10 16:35	8D-1 8D-2 8D-3 8D-4 8D-4 7) Agarwal 9B-1 9B-2 9B-3	Invited Invited Invited Invited	Focus Session 3: Packaging and Heterogeneous Integration Fukushima  Laser-Assisted Bonding (LAB), Its Bonding Materials, and Their Applications  System-level Power Integrity Optimization Based on High-Density Capacitors for Enabling HPC/AI Applications  Multilithic 3D and Heterogeneous Integration Using Capillary Self-Assembly  Surface Planarization of Polymeric Dielectrics for FOWLP Applications  Authors' Interview / Coffee Break  Room A (Matahari II)  RF Device Modeling  erre Raskin  SOI Devices and Substrates Towards RF and Millimeter Wave ICs  Modeling and Design of SiC-based High-Frequency Photoconductive Switches  Geometrical Dimension Impact for Performance of CMOS Based Compatible  Circular Shape Aluminum Nitride (AIN) Piezoelectric Micromachined Ultrasonic	Sungwook Moon  Takafumi Fukushima  Sungdong Kim  Jean-Pierre Raskin  Shaloo Rakheja  Muhammad Naim Haron	Research Institute  Samsung Electronics Co. Ltd.  Tohoku University  Seoul National University of Science ar Technology  Université Catholique de Louvain  University of Illinois at Urbana-Champaign  Universiti Sains Malaysia
ession hairs: 3:20 3:45 4:10 4:35 5:00-15 5:20-17 ession hairs: 5:20	8D Piyush (13:45) 14:10 14:35 15:00 6:20 6:20 6:7:00 9B Harshit 15:45 16:10 16:35 17:00	8D-1 8D-2 8D-3 8D-4 7) Agarwal 9B-1 9B-2	Invited Invited Invited Invited	Focus Session 3: Packaging and Heterogeneous Integration Fukushima  Laser-Assisted Bonding (LAB), Its Bonding Materials, and Their Applications  System-level Power Integrity Optimization Based on High-Density Capacitors for Enabling HPC/AI Applications  Multilithic 3D and Heterogeneous Integration Using Capillary Self-Assembly  Surface Planarization of Polymeric Dielectrics for FOWLP Applications  Authors' Interview / Coffee Break  Room A (Matahari II)  RF Device Modeling  erre Raskin  SOI Devices and Substrates Towards RF and Millimeter Wave ICs  Modeling and Design of SiC-based High-Frequency Photoconductive Switches  Geometrical Dimension Impact for Performance of CMOS Based Compatible	Sungwook Moon  Takafumi Fukushima  Sungdong Kim  Jean-Pierre Raskin  Shaloo Rakheja	Research Institute  Samsung Electronics Co. Ltd.  Tohoku University  Seoul National University of Science ar Technology  Université Catholique de Louvain  University of Illinois at Urbana-Champaign

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